

STF5N80K5

N-channel 800 V, 1.50 Ω typ., 4 A MDmesh™ K5 Power MOSFET in a TO-220FP package

Datasheet - production data



Figure 1: Internal schematic diagram



Features

Order code	VDS	R _{DS(on)} max.	ID	
STF5N80K5	800 V	1.75 Ω	4 A	

- Industry's lowest R_{DS(on)} x area
- Industry's best FoM (figure of merit)
- Ultra-low gate charge
- 100% avalanche tested
- Zener-protected

Applications

• Switching applications

Description

This very high voltage N-channel Power MOSFET is designed using MDmesh[™] K5 technology based on an innovative proprietary vertical structure. The result is a dramatic reduction in on-resistance and ultra-low gate charge for applications requiring superior power density and high efficiency.

Table 1: Device summary

Order code	Marking	Package	Packing
STF5N80K5	5N80K5	TO-220FP	Tube

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This is information on a product in full production.

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1 Electrical ratings

Table 2: Absolute maximum ratings

Symbol	Parameter	Value	Unit
Vgs	Gate-source voltage	± 30	V
ID	Drain current (continuous) at T_C = 25 °C	4	А
ΙD	Drain current (continuous) at T _c = 100 °C	2.3	А
ID ⁽¹⁾	Drain current (pulsed)	16	А
P _{TOT}	Total dissipation at $T_c = 25 \text{ °C}$	20	W
dv/dt (2)	Peak diode recovery voltage slope	4.5	
dv/dt ⁽³⁾	MOSFET dv/dt ruggedness	50	V/ns
Viso	Insulation withstand voltage (RMS) from all three leads to external heat sink (t=1 s; T_c= 25 °C)	2500	V
Tj	Operating junction temperature range	- 55 to	℃
T _{stg}	Storage temperature range	150	C

Notes:

 $^{(1)}\mbox{Pulse}$ width limited by safe operating area

 $^{(2)}I_{SD}$ \leq 4 A, di/dt =100 A/µs; V_Ds peak < V(_BR)DSS, V_DD = 640 V $^{(3)}V_{DS}$ \leq 640 V

Table 3: Thermal data

Symbol	Parameter	Value	Unit
R _{thj-case}	Thermal resistance junction-case	6.25	°C/W
R _{thj-amb}	Thermal resistance junction-ambient	62.5	°C/W

Table 4: Avalanche characteristics

Symbol	Parameter	Value	Unit
I _{AR}	Avalanche current, repetitive or not repetitive (pulse width limited by Tjmax)		А
Eas	Single pulse avalanche energy (starting $T_j = 25$ °C, $I_D = I_{AR}$, $V_{DD} = 50$ V)	165	mJ



2 Electrical characteristics

 $T_C = 25$ °C unless otherwise specified

Table 5: On/off-state							
Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit	
V(BR)DSS	Drain-source breakdown voltage	V_{GS} = 0 V, I_D = 1 mA	800			V	
		$V_{GS} = 0 V, V_{DS} = 800 V$			1	μA	
IDSS	Zero gate voltage drain current	$V_{GS} = 0 V, V_{DS} = 800 V$ T _c = 125 °C ⁽¹⁾			50	μA	
I _{GSS}	Gate body leakage current	V_{DS} = 0 V, V_{GS} = ±20 V			±10	μA	
V _{GS(th)}	Gate threshold voltage	$V_{DD} = V_{GS}$, $I_D = 100 \ \mu A$	3	4	5	V	
R _{DS(on)}	Static drain-source on-resistance	V_{GS} = 10 V, I_D = 2 A		1.50	1.75	Ω	

Table 5: On/off-state

Notes:

⁽¹⁾Defined by design, not subject to production test

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
Cymbol	T diameter	rest conditions		· yp.	max.	Unit
Ciss	Input capacitance		-	177	-	pF
Coss	Output capacitance	V _{DS} = 100 V, f = 1 MHz, V _{GS} = 0 V	-	15	-	pF
Crss	Reverse transfer capacitance		-	0.3	-	pF
C _{o(tr)} ⁽¹⁾	Equivalent capacitance time related	V _{DS} = 0 to 640 V, V _{GS} = 0 V	-	33	-	pf
$C_{o(er)}^{(2)}$	Equivalent capacitance energy related	$v_{\rm DS} = 0.10.040 v, v_{\rm GS} = 0.0$	-	12	-	pf
Rg	Intrinsic gate resistance	f = 1 MHz , I _D = 0 A	-	16	-	Ω
Qg	Total gate charge	$V_{DD} = 640 \text{ V}, \text{ I}_{D} = 4 \text{ A}$	-	5	-	nC
Q _{gs}	Gate-source charge	V _{GS} = 10 V	-	1.7	-	nC
Q _{gd}	Gate-drain charge	see Figure 15: "Test circuit for gate charge behavior"	-	2.9	-	nC

Table 6: Dynamic

Notes:

 $^{(1)}C_{0(tr)}$ is a constant capacitance value that gives the same charging time as C_{oss} while V_{DS} is rising from 0 to 80% V_{DSS} .

 $^{(2)}C_{0(er)}$ is a constant capacitance value that gives the same stored energy as C_{oss} while V_{DS} is rising from 0 to 80% V_{DSS} .



Electrical characteristics

Table 7: Switching times							
Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit	
t _{d(on)}	Turn-on delay time	$V_{DD}\text{=}\;400\;V,I_{D}=2\;A,R_{G}\text{=}\;4.7\;\Omega$	-	12.7	-	ns	
tr	Rise time	V _{GS} = 10 V	-	11.7	-	ns	
t _{d(off)}	Turn-off delay time	see Figure 14: "Test circuit for resistive load switching times" and Figure 19: "Switching time waveform"	-	23	-	ns	
t _f	Fall time		-	14.8	-	ns	

Table 8: Source-drain diode

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
Isd	Source-drain current		-		4	А
Isdm ⁽¹⁾	Source-drain current (pulsed)		-		16	А
V _{SD} ⁽²⁾	Forward on voltage	$I_{SD} = 4 \text{ A}, \text{ V}_{GS} = 0 \text{ V}$	-		1.6	V
t _{rr}	Reverse recovery time	$I_{SD} = 4 \text{ A}, \text{ di/dt} = 100 \text{ A/}\mu\text{s},$	-	265		ns
Qrr	Reverrse recovery charge	V _{DD} = 60 V see <i>Figure 16: "Test circuit</i>	-	1.59		μC
IRRM	Reverse recovery current	for inductive load switching and diode recovery times"	-	12		А
trr	Reverse recovery time	$I_{SD} = 4 \text{ A}, \text{ di/dt} = 100 \text{ A/}\mu\text{s},$	-	386		ns
Qrr	Reverse recovery charge	$V_{DD} = 60 \text{ V}, \text{ T}_{j} = 150 ^{\circ}\text{C}$ see Figure 16: "Test circuit for inductive load switching and diode recovery times"	-	2.18		μC
Irrm	Reverse recovery current		-	11.3		A

Notes:

⁽¹⁾Pulse width limited by safe operating area

 $^{(2)}\text{Pulsed:}$ pulse duration = 300 $\mu\text{s},$ duty cycle 1.5%

Table 9: Gate-source Zener diode

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
V _(BR) GSO	Gate-source breakdown voltage	I _{GS} = ± 1mA, I _D = 0 A	30	-	-	V

The built-in back-to-back Zener diodes are specifically designed to enhance the ESD performance of the device. The Zener voltage facilitates efficient and cost-effective device integrity protection, thus eliminating the need for additional external componentry.



2

0



V_{GS}=7 V V_{GS}=6 V

16

V_{DS} (V)

12

8

4



0

4 5 6

8 9 10 11



V_{GS} (V)

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3 Test circuits









4 Package information

In order to meet environmental requirements, ST offers these devices in different grades of ECOPACK[®] packages, depending on their level of environmental compliance. ECOPACK[®] specifications, grade definitions and product status are available at: *www.st.com*. ECOPACK[®] is an ST trademark.









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(5			Package information
	Table 10: TO-220FP pa	ackage mechanical data	
Dim.		mm	
Dim.	Min.	Тур.	Max.
A	4.4		4.6
В	2.5		2.7
D	2.5		2.75
E	0.45		0.7
F	0.75		1
F1	1.15		1.70
F2	1.15		1.70
G	4.95		5.2
G1	2.4		2.7
Н	10		10.4
L2		16	
L3	28.6		30.6
L4	9.8		10.6
L5	2.9		3.6
L6	15.9		16.4
L7	9		9.3
Dia	3		3.2



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Table 11: Document revision history

Date	Revision	Changes
16-Oct-2015	1	First release.
06-Nov-2015	2	Updated title in cover page.
09-May-2016	3	Modified: title Table 2: "Absolute maximum ratings", Table 3: "Thermal data", Table 5: "On/off-state", Table 6: "Dynamic", Table 7: "Switching times", Table 8: "Source-drain diode" Added: Section 3.1: "Electrical characteristics (curves)" Modified: Section 4: "Test circuits" Minor text changes





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